

<b>ASC OP1 Performance Based Imperfection Standard Meeting in Rochester, NY, October 8, 2006</b>			
<b>Last</b>	<b>First</b>	<b>Representing</b>	<b>Attendance</b>
Aikens	David	Zygo Corporation	Yes
Boulton	Gordon	JDSU	Yes
Brunfeld	Andrei	XYRATEX	
Catching	Ben	JDSU	No
Dombrowski	Frank	Gage-Line Technology, Inc.	Yes
Dowell	Marla	IEE/LEOS (NIST)	Yes
Endelman	Lincoln	SPIE (Endelman Enterprises)	Phone
Gaugh	Charles	Davidson Optronics, Inc.	
Hamilton	John	Northrop Grumman	No
Hitz	Breck	LEOMA	
Royall	William	Retired (Kodak)	Yes
Turner	Trey	Research Electro-Optics, Inc.	Yes

In Person	6
By Phone	1
Total	7